

## Normally – OFF Silicon Carbide Junction Transistor

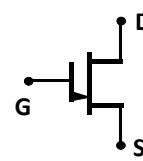
<b>V<sub>DS</sub></b>	=	<b>650 V</b>
<b>V<sub>DS(ON)</sub></b>	=	<b>1.7 V</b>
<b>I<sub>D</sub></b>	=	<b>4 A</b>
<b>R<sub>DS(ON)</sub></b>	=	<b>425 mΩ</b>

### Features

- 250 °C maximum operating temperature
- Temperature independent switching performance
- Electrically isolated base-plate
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- Low gate charge
- Low intrinsic capacitance

### Package

- RoHS Compliant



**TO – 257 (Isolated Base-plate Hermetic Package)**

### Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- High short circuit withstand capability

### Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

### Maximum Ratings at T<sub>j</sub> = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V	650	V
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> = 165 °C	4	A
Gate Peak Current	I <sub>GM</sub>		5	A
Reverse Gate – Source Voltage	V <sub>GS</sub>		30	V
Reverse Drain – Source Voltage	V <sub>DS</sub>		40	V
Power Dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25 °C	7	W
Operating and Storage Temperature	T <sub>j</sub> , T <sub>stg</sub>		-55 to 250	°C

### Electrical Characteristics at T<sub>j</sub> = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
<b>On Characteristics</b>						
Drain – Source On Voltage	V <sub>DS(ON)</sub>	I <sub>D</sub> = 4 A, I <sub>G</sub> = 100 mA, T <sub>j</sub> = 25 °C I <sub>D</sub> = 4 A, I <sub>G</sub> = 250 mA, T <sub>j</sub> = 175 °C I <sub>D</sub> = 4 A, I <sub>G</sub> = 250 mA, T <sub>j</sub> = 250 °C	1.7 3.2 4.7	2.2 4.0 5.5		V
Drain – Source On Resistance	R <sub>DS(ON)</sub>	I <sub>D</sub> = 4 A, I <sub>G</sub> = 100 mA, T <sub>j</sub> = 25 °C I <sub>D</sub> = 4 A, I <sub>G</sub> = 250 mA, T <sub>j</sub> = 175 °C I <sub>D</sub> = 4 A, I <sub>G</sub> = 250 mA, T <sub>j</sub> = 250 °C	425 800 1180			mΩ
Gate Forward Voltage	V <sub>GS(FWD)</sub>	I <sub>G</sub> = 500 mA, T <sub>j</sub> = 25 °C I <sub>G</sub> = 500 mA, T <sub>j</sub> = 250 °C	3.3 3.2			V
DC Current Gain	β	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 5 A, T <sub>j</sub> = 25 °C V <sub>DS</sub> = 5 V, I <sub>D</sub> = 5 A, T <sub>j</sub> = 250 °C	90 60	110 80		

### Off Characteristics

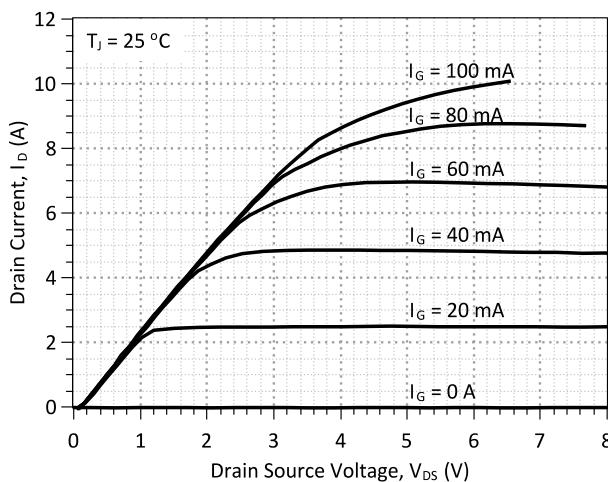
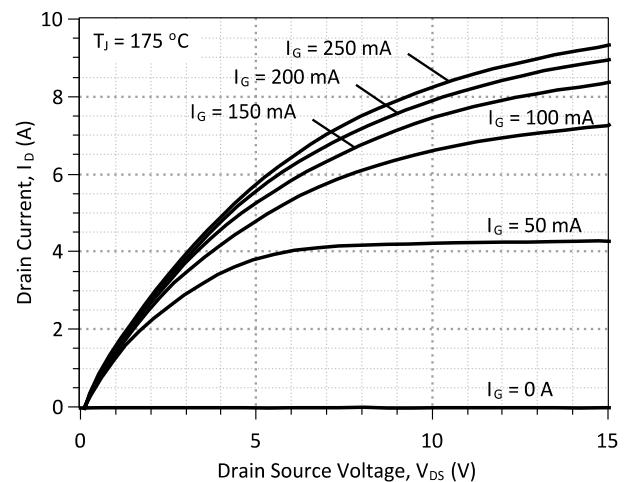
Drain Leakage Current	I <sub>DSS</sub>	V <sub>R</sub> = 650 V, V <sub>GS</sub> = 0 V, T <sub>j</sub> = 25 °C V <sub>R</sub> = 650 V, V <sub>GS</sub> = 0 V, T <sub>j</sub> = 175 °C V <sub>R</sub> = 650 V, V <sub>GS</sub> = 0 V, T <sub>j</sub> = 250 °C	0.1 1 10	10 50 100	μA
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**Electrical Characteristics at  $T_J = 250^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Values		
			min.	typ.	max.
<b>Dynamic Characteristics</b>					
Input Capacitance	$C_{iss}$	$V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, T_J = 25^\circ\text{C}$	324		pF
Output Capacitance	$C_{oss}$		45		pF
Reverse Transfer Capacitance	$C_{rss}$		45		pF
<b>Switching Characteristics</b>					
Turn On Delay Time	$t_{d(on)}$	$V_{DD} = 400 \text{ V}, I_D = 5 \text{ A}, R_{G(on)} = R_{G(off)} = 44 \Omega, V_{GS} = -8/15 \text{ V}, T_J = 175^\circ\text{C}$ Refer to Figure 10 for gate drive current waveforms	5		ns
Rise Time	$t_r$		15		ns
Turn Off Delay Time	$t_{d(off)}$		74		ns
Fall Time	$t_f$		14		ns
Turn-On Energy Per Pulse	$E_{on}$		24		$\mu\text{J}$
Turn-Off Energy Per Pulse	$E_{off}$		7		$\mu\text{J}$
Total Switching Energy	$E_{ts}$		31		$\mu\text{J}$
Turn On Delay Time	$t_{d(on)}$		9		ns
Rise Time	$t_r$	$V_{DD} = 400 \text{ V}, I_D = 5 \text{ A}, R_{G(on)} = R_{G(off)} = 44 \Omega, V_{GS} = -8/15 \text{ V}, T_J = 250^\circ\text{C}$ Refer to Figure 10 for gate drive current waveforms	24		ns
Turn Off Delay Time	$t_{d(off)}$		114		ns
Fall Time	$t_f$		17		ns
Turn-On Energy Per Pulse	$E_{on}$		54		$\mu\text{J}$
Turn-Off Energy Per Pulse	$E_{off}$		10		$\mu\text{J}$
Total Switching Energy	$E_{ts}$		64		$\mu\text{J}$

**Thermal Characteristics**

Thermal resistance, junction - case	$R_{thJC}$	4.2	$^\circ\text{C/W}$
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**Figure 1: Typical Output Characteristics at  $25^\circ\text{C}$** 

**Figure 2: Typical Output Characteristics at  $175^\circ\text{C}$**

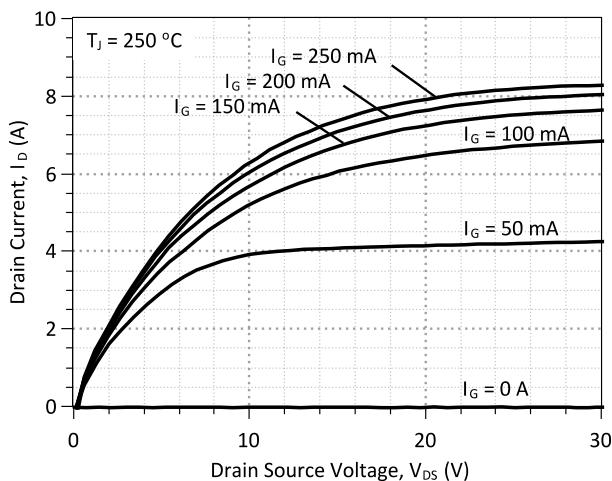


Figure 3: Typical Output Characteristics at 250 °C

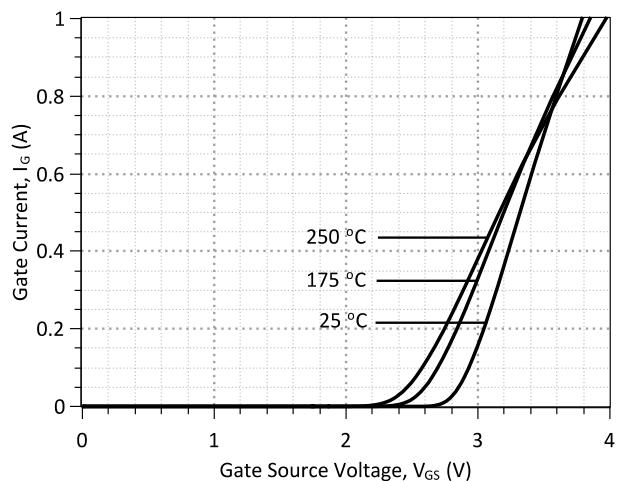


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

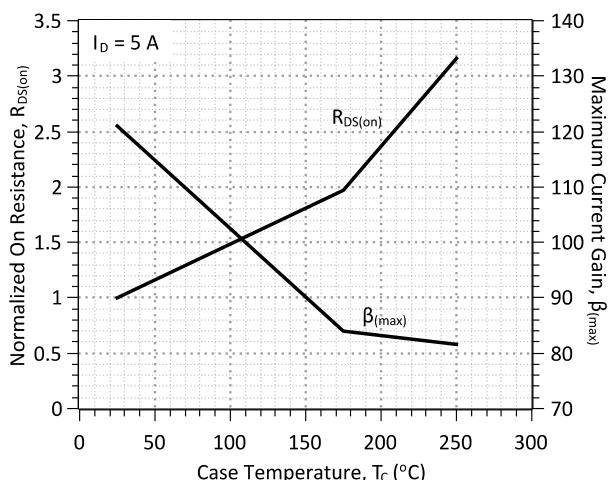


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

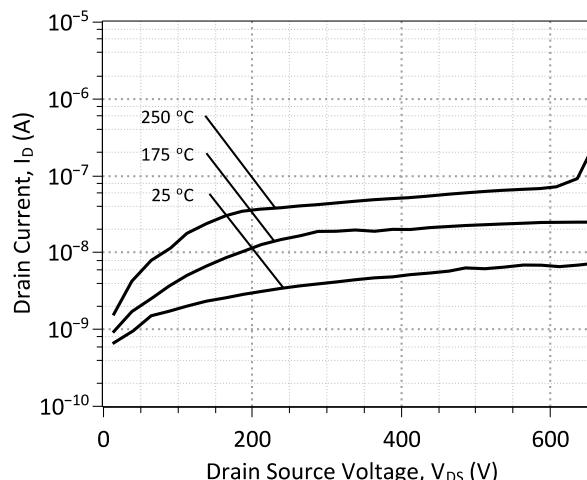


Figure 6: Typical Blocking Characteristics

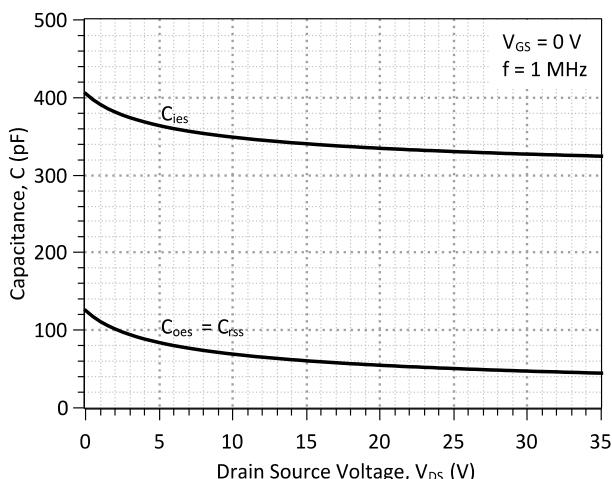


Figure 7: Typical Capacitance vs Drain-Source Voltage

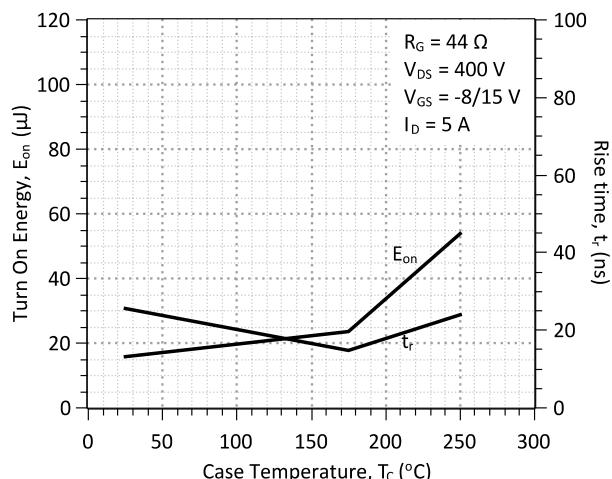
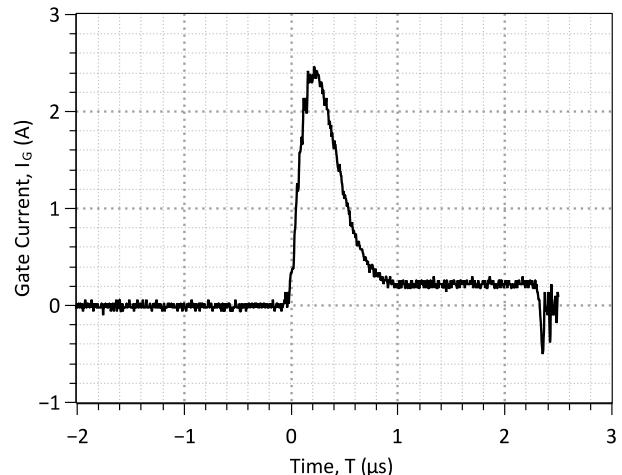
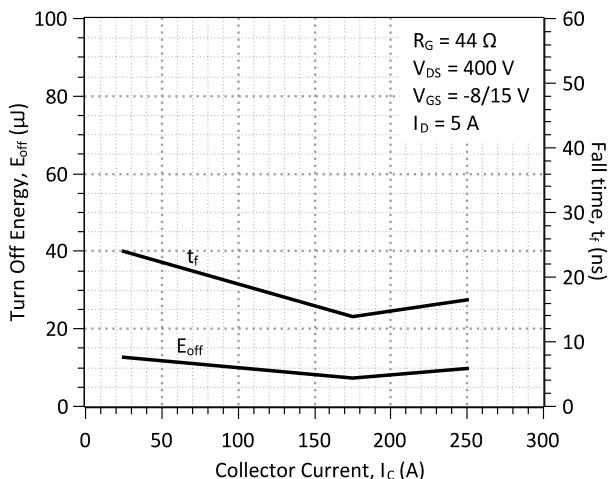
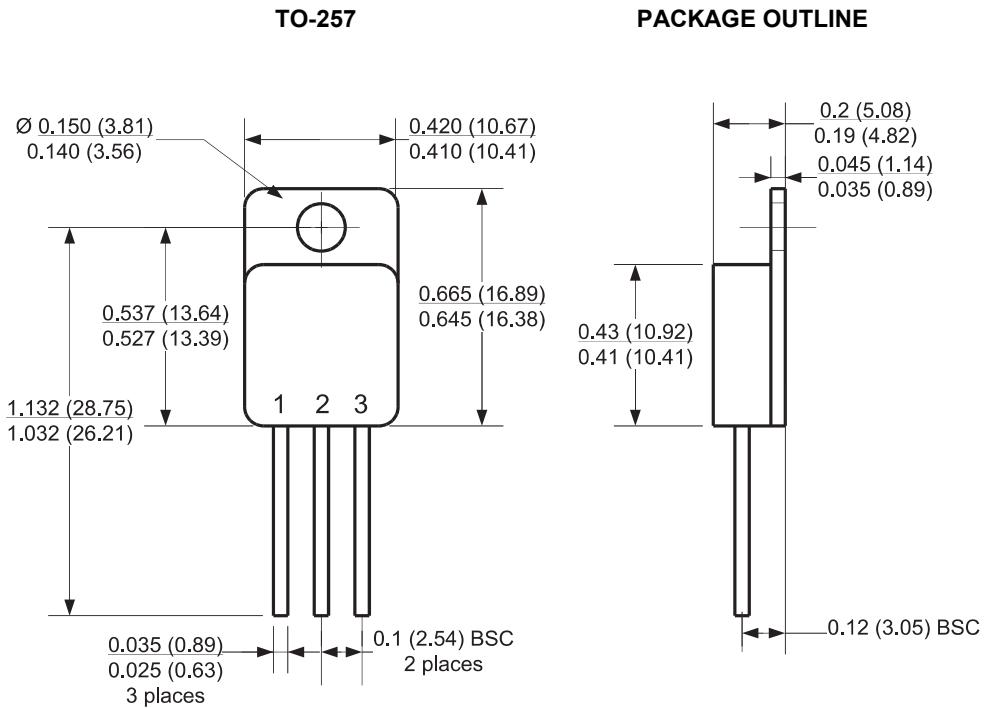


Figure 8: Typical Turn On Energy Losses and Switching Times vs. Temperature



### Package Dimensions:



### NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

<b>Revision History</b>			
Date	Revision	Comments	Supersedes
2013/11/18	1	Updated Electrical Characteristics	
2012/08/24	0	Initial release	

## Published by

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## SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 2N7635-GA device.

```
* MODEL OF GeneSiC Semiconductor Inc.  
*  
* $Revision: 1.0      $  
* $Date: 06-SEP-2013 $  
*  
* GeneSiC Semiconductor Inc.  
* 43670 Trade Center Place Ste. 155  
* Dulles, VA 20166  
* http://www.genesicsemi.com/index.php(hit-sic/sjt)  
*  
* COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.  
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*  
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY  
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED  
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A  
* PARTICULAR PURPOSE."  
* Models accurate up to 2 times rated drain current.  
*  
.model 2N7635 NPN  
+ IS      1.22E-47  
+ ISE     3.91E-27  
+ EG      3.23  
+ BF      110  
+ BR      0.55  
+ IKF     999  
+ NF      1  
+ NE      2.022  
+ RB      0.26  
+ RE      0.231  
+ RC      0.16  
+ CJC     1.37E-10  
+ VJC     3.173990516  
+ MJC     0.436428533  
+ CJE     3.36E-10  
+ VJE     2.944816511  
+ MJE     0.493905327  
+ XTI     3  
+ XTB     -0.45  
+ TRC1    1.50E-02  
+ VCEO    650  
+ ICRATING 4  
+ MFG     GeneSiC_Semiconductor  
*  
* End of 2N7635-GA SPICE Model
```